

Search Notes

Application/Control No.

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Examiner

Noah Kamen

Applicant(s)/Patent under
Reexamination

KAMIYAMA ET AL.

Art Unit

3747

SEARCHED

Class	Subclass	Date	Examiner
search	updated	10/16/2007	/NK/

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR